


<b>Search Notes</b>  	<b>Application/Control No.</b>  10554159	<b>Applicant(s)/Patent Under Reexamination</b>  VEITS, OLIVER
	<b>Examiner</b>  JEFFREY M RUTKOWSKI	<b>Art Unit</b>  2619

### SEARCHED

Class	Subclass	Date	Examiner
370	389, 392, 352, 401 (NAT traversal concepts)	06/25/2008	JMR
709	223, 228, 245 (NA traversal concepts)T	06/25/2008	JMR

### SEARCH NOTES

Search Notes	Date	Examiner
searched IEEE for SIP NAT traversal using STUN concepts	06/25/2008	JMR
searched EAST for STUN NAT traversal concepts	06/25/2008	JMR
searched EAST for SIP NAT concepts	06/25/2008	JMR

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner